

**Search Notes**

Application/Control No.

10/824,659

Examiner

Hieu Nguyen

Applicant(s)/Patent under  
Reexamination

WONG ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
330	298	9/12/2005	HN
330	207P	9/12/2005	HN
330	51	9/13/2005	HN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
330	298	9/14/2005	HN
330	207P	9/14/2005	HN
330	51	9/14/2005	HN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
MOTTOLA STEVEN J	9/12/2005	HN
NGUYEN KHANH V	9/12/2005	HN